

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Yamazaki, et al.

Art Unit : 2813

Serial No.: 09/898,986 Examiner : Laura Schillinger

Filed July 3, 2001

Title : SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE

SAME

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Supplemental to the Information Disclosure Statement filed with this application on July 3, 2001, Applicant submits the attached Form PTO-1449, listing references that are of record in parent cases having Applicant Nos. 09/272,701 (filed March 18, 1999) and 08/890,591 (filed July 8, 1997).

Although the listed references are of record in this Application, as well as in the abovementioned parent applications, this IDS is being filed to provide, for the Examiner's convenience in initialing, a clean listing of the references on the attached Form PTO-1449.

The references cited on the attached Form PTO-1449 were submitted to and/or cited by the Office in the prior applications and, therefore under Rule 97(d), are not provided in this application.

Inasmuch as the listed references are of record in the above-mentioned parent cases (and because the listed references were included with the July 3 IDS), no fee is believed to be due. In the event that any fee is due, please apply any charges or credit any overpayment to Deposit Account No. 06-1050.

Fish & Richardson P.C. 1425 K Street, N.W., 11th Floor Washington, DC 20005-3500 Telephone: (202) 783-5070

Facsimile: (202) 783-2331

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Respectfully submitted,

William G. Hughes,

Reg. No. 46,112

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Sheet	-1	of	-1

Substitute Form PTO-1449
U.S. Department of Commerce (Modified)
Patent and Trademark Office
OIP
Intermation Disclosure Statement
by Applicant
Yamazaki, et al.

Filing Date
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Application No.
07977-163003

Application No.
09/898,986

Applicant
Yamazaki, et al.

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2813

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,898,204	4/1999	Watanabe			
	AB	5,998,854	12/1999	Morishita et al.			
	AC	6,180,957	1/2001	Miyasaka et al.			
	AD	5,550,397	08/27/96	Lifshitz et al.			
	AE	5,552,624	09/03/96	Shotnicki et al.			
	AF	5,616,935	04/01/97	Koyama et al.			
	AG	5,659,192	08/19/97	Sarma et al.			
	АН	5,726,459	03/10/98	Hsu et al.			
	AI						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication	Country or			Trans	lation
IIIIIai	IU	Number	Date	Patent Office	Class	Subclass	Yes	No
	AJ	04-206971	07/28/92	JAPAN				
	AK	04-286339	10/12/92	JAPAN				
	AL	06-232059	08/19/94	JAPAN			2	
	AM	07-169974	07/04/95	JAPAN				西
	AN	07-176753	07/14/95	JAPAN		ļ.	8 -	巴
	AO	07/321339	12/08/95	JAPAN		+	CE	. 1

Other Documents (include Author, Title, Date, and Place of Publication)					
Examiner	Desig.	86			
Initial	_ ID ¯	Document 5			
	AP	Wang et al., Enhanced Performance of Accumulation Mode 0.5 μm CMOS/SOI Operated at 300 K and 85 K, IEEE, IEDM 91, pp. 679-682.			
	AQ	Fossum et al., "Anomalous Leadage Current in LPCVD Polysilicon MOSFET's", September 1995, IEEE Transactions on Electron Devices, Vol. ED-32, No. 9; pp. 1878-1884.			
	AR	Qian et al., "Inversion/Accumulation-Mode Polysilicon Thin-Film Transistors: Characterization and Unified Molding", September 1988, IEEE Transactions on Electron Devices, Vol. 35, pp. 1501-1509.			
	AS	Malhi et al., "p-Channel MOSFET's in LPCVD Polysilicon", October 1983, IEEE Electron Device Letters, Vol. EDL-4, No. 10, pp. 369-371.			

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if no next communication to applicant	t in conformance and not considered. Include copy of this form with